Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/517,114	TANG ET AL.		
Examiner	Art Unit		
TUAN A. PHAM	2618		

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Class	Subclass	Date	Examiner
455	424	12/6/2006	PHAM
	425		
	452.1		
	456.5		
	456.5	12/6/2006	PHAM

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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